## Notice of References Cited Application/Control No 09/629,607 Examiner Mark Spisich Applicant(s)/Patent Under Reexamination LUKAS ET AL Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-1414886	05-1922	Matsunaga	15/176 4
	В	US-4880382	11-1989	Moret et al	433/118
	С	US-5421726	06-1995	Okada	15/22 1 X
	D	US-5471695	12-1995	Aiyar	15/22.1
	Ē	US-5947912	09-1999	Montagnino	606/161 X
	F	US-5987681	11-1999	Hahn et al	15/22.1
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.